TS6454US

10/584379 RST:BAF

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Commissioner for Patents. Mail Store PCT. Alexandria, VA 20212 1450 Commissioner for Patents, Mail Stop PCT, Alexandria, VA 22313-1450 on or

before the date shown below

Barbara Fisher Date: June 27, 2006

## THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PCT International Application of	
BEST, Adam Samuel, et al.	) )
Int. Appln No.: PCT/EP2004/053182	) )
Intl. Filing Date: 30 November 2004	) )
ELECTROCHEMICAL ELEMENT FOR USE AT HIGH	) )
TEMPERATURES	June 27, 2006

COMMISSIONER FOR PATENTS Mail Stop PCT (DO/EO/US) Alexandria, VA 22313-1450

## **INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. 1.56 AND 1.97**

Dear Sir:

It is respectfully requested that the documents listed on the attached Form PTO-1449 be considered by the Patent and Trademark Office in the above-entitled application and made of record therein. Full text copies of the relevant foreign documents and literature are enclosed.

The Examiner is requested to fully consider this information and to indicate consideration on the attached PTO-1449 (Modified) by initialing next to each item submitted by the Applicant(s).

Respectfully submitted,

BEST, Adam Samuel, et al.

Patent Agent, Rachael A. Stiegel

Reg. No. 54,469 (713) 241-1842 (713) 241-6617

P.O. Box 2463 One Shell Plaza

Houston, Texas 77252-2463

Enclosures: Form PTO-1449 (Modified)

FORM PTO-1449 (Modified)

ATTY. DOCKET NO. TS6454

APPLICATION NUMBER

LIST OF INFORMATION PROVIDED BY APPLICANT

APPLICANT BEST, Adam Samuel, et al.

(Use several sheets if necessary)

FILING DATED 1004C GROUP ART UNIT

reference	DES:	<b>EGNATION</b>	U.S. P.	ATENT DOCUMENTS					
Examiner Initial		Document No.	Date	Patentee	Class	Subclass	Filing Date if Appropriate		
	AA	5855809	1/5/99	Charles Austen Angell, et al	252	62.2	11/12/96		
	AB	6552843	4/22/03	D. Morgan Tench, et al	359	321	1/31/02		
	AC	6326104	12/4/01	Josip Caja, et al	429	188	10/14/99		
	AD	5965054	10/12/99	Alan B. McEwen, et al	252	62.2	8/12/97		
	AE	5827602	10/27/98	Victor R. Koch, et al	429	194	9/17/97		
	AF								
	AG								
	AH								
	ΑI								
	АJ								
	AK								
			Foreign	PATENT DOCUMENTS					
		Document No.	Date	Country	Class	Subclass	Translation Yes No		
	AL	02/063073	8/15/02	WO	C25F	1/00			
	AM	01/80344	10/25/01	WO	H01M	10/36			
	AN	01/15258	3/1/01	wo	H01M	10/40			
	AO	02/09215	1/31/02	wo	H01M	6/00			
	OT			HOR, TITLE, DATE,					
	AR	International S	earch Report	of PCT/EP2004/053	182 date	d 18 Febru	ary 2005		
	AS	Macfarlane D R , et al: "Pyroolidinium imides: a new family of molten salts and conductive plastic crystal phases" 20 May 19999, Jrnl. of Physical Chemistry. B, Materials, Surfaces, Interfaces and Biophysical, Washington, DC, US, pgs 4164-4170,							
	АТ								
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Initial if citation considered, whether or not citation is in conformance with MPEP \$ 609. Draw line EXAMINER: through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

The attached cited information should not be construed as an admission that any of the above items are prior art to the subject invention.

FORM PTO-1449 (Modified)

ATTY. DOCKET NO.

APPLICATION NUMBER

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BEST, Adam Samuel, et al.

FILING DATE AD20 RECUPETIVE 0 27 JUN 2006

REFERENCE	DESI	GNATION	U.S. I	PATENT DOCUMENTS				Ç
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	AA							
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	AD							
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			FOREIGN	PATENT DOCUMENTS				•
		Document No.	Date	Country	Class	Subclass	Translat Yes	No
	AL	2004/082059	9/23/04	wo	H01M	10/26		
	AM							
	AN							
	AO						•	
	OT	HER DOCUMENTS (IN	CLUDING AUT	HOR, TITLE, DATE,	PERTINEN	r Pages, E	rc.)	
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	AS							
	АТ	·						
EXAMINER	1	<u> </u>		DATE CONSIDERED				

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applicant. The attached cited information should not be construed as an admission that any of the above items are prior art to the subject invention.